

PROCEEDINGS OF SPIE

# ***Optical and Quantum Sensing and Precision Metrology II***

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Selim M. Shahriar**  
*Editors*

**22–27 January 2022  
San Francisco, California, United States**

**20–24 February 2022  
ONLINE**

*Sponsored and Published by*  
SPIE

**Volume 12016**

Proceedings of SPIE 0277-786X, V. 12016

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Optical and Quantum Sensing and Precision Metrology II, edited by  
Jacob Scheuer, Selim M. Shahriar, Proc. of SPIE Vol. 12016, 1201601  
© 2022 SPIE · 0277-786X · doi: 10.1117/12.2634583

Proc. of SPIE Vol. 12016 1201601-1

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Please use the following format to cite material from these proceedings:  
Author(s), "Title of Paper," in *Optical and Quantum Sensing and Precision Metrology II*, edited by Jacob Scheuer, Selim M. Shahriar, Proc. of SPIE 12016, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X  
ISSN: 1996-756X (electronic)

ISBN: 9781510649033  
ISBN: 9781510649040 (electronic)

Published by  
**SPIE**  
P.O. Box 10, Bellingham, Washington 98227-0010 USA  
Telephone +1 360 676 3290 (Pacific Time)  
[SPIE.org](http://SPIE.org)  
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